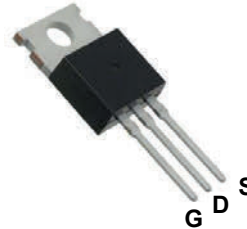
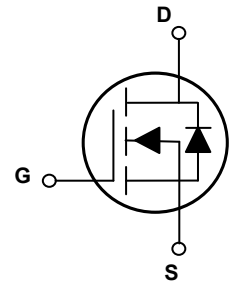


### Main Product Characteristics

$V_{(BR)DSS}$	600V
$R_{DS(ON)}$	0.36Ω (max.)
$I_D$	11A



TO-220



Schematic Diagram

### Features and Benefits

- Advanced MOSFET process technology
- Ideal for high efficiency switched mode power supplies
- Low on-resistance with low gate charge
- Fast switching and reverse body recovery



### Description

The GSJH60R360 utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supplies and a wide variety of other applications.

### Absolute Maximum Ratings ( $T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DS}$	600	V
Gate-to-Source Voltage	$V_{GS}$	$\pm 30$	V
Continuous Drain Current, @ Steady-State ( $T_C=25^\circ\text{C}$ )	$I_D$	11	A
Continuous Drain Current, @ Steady-State ( $T_C=100^\circ\text{C}$ )		7	A
Pulsed Drain Current	$I_{DM}$	44	A
Power Dissipation ( $T_C=25^\circ\text{C}$ )	$P_D$	89	W
		0.71	W/ $^\circ\text{C}$
Single Pulse Avalanche Energy <sup>1</sup>	$E_{AS}$	310	mJ
Single Pulse Avalanche Current	$I_{AS}$	2.6	A
Body Diode Reverse Voltage Slope <sup>2</sup>	dv/dt	50	V/ns
MOS dv/dt Ruggedness <sup>3</sup>	dv/dt	100	V/ns
Junction-to-Ambient (PCB Mounted, Steady-State)	$R_{\theta JA}$	62	$^\circ\text{C}/\text{W}$
Junction-to-Case	$R_{\theta JC}$	1.4	$^\circ\text{C}/\text{W}$
Operating Junction and Storage Temperature Range	$T_J/T_{STG}$	-55 to +150	$^\circ\text{C}$
Soldering Temperature	$T_{sold}$	260	$^\circ\text{C}$

### Electrical Characteristics ( $T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
<b>On / Off Characteristics</b>						
Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=250\mu A$	600	-	-	V
Drain-to-Source Leakage Current	$I_{DSS}$	$V_{DS}=600V, V_{GS}=0V, T_J=25^\circ\text{C}$	-	-	1.0	$\mu A$
		$V_{DS}=600V, V_{GS}=0V, T_J=125^\circ\text{C}$	-	1.5	-	$\mu A$
Gate-to-Source Forward Leakage	$I_{GSS}$	$V_{DS}=0V, V_{GS}=30V$	-	-	100	nA
		$V_{DS}=0V, V_{GS}=-30V$	-	-	-100	
Static Drain-to-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=5.5A$	-	0.3	0.36	$\Omega$
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	2.5	-	4.0	V
<b>Dynamic and Switching Characteristics</b>						
Input Capacitance	$C_{iss}$	$V_{GS}=0V, V_{DS}=100V, f=1\text{MHz}$	-	925	-	pF
Output Capacitance	$C_{oss}$		-	35	-	
Reverse Transfer Capacitance	$C_{rss}$		-	1.0	-	
Total Gate Charge <sup>4,5</sup>	$Q_g$	$I_D=11A, V_{DD}=480V, V_{GS}=10V$	-	30	-	nC
Gate-to-Source Charge <sup>4,5</sup>	$Q_{gs}$		-	7.5	-	
Gate-to-Drain ("Miller") Charge <sup>4,5</sup>	$Q_{gd}$		-	15	-	
Gate Plateau <sup>4,5</sup>	$V_{plateau}$		-	6.7	-	V
Turn-On Delay Time <sup>4,5</sup>	$t_{d(on)}$	$V_{DD}=300V, V_{GS}=10V, R_G=10\Omega, I_D=11A$	-	15	-	nS
Rise Time <sup>4,5</sup>	$t_r$		-	30	-	
Turn-Off Delay Time <sup>4,5</sup>	$t_{d(off)}$		-	45	-	
Fall Time <sup>4,5</sup>	$t_f$		-	25	-	
Gate Resistance	$R_g$	$f=1\text{MHz}$	-	3.7	-	$\Omega$
<b>Source-Drain Ratings and Characteristics</b>						
Continuous Source Current (Body Diode)	$I_S$	$T_C=25^\circ\text{C}$ , MOSFET symbol showing the integral reverse p-n junction diode.	-	-	11	A
Diode Pulse Current	$I_{S, pulse}$		-	-	44	A
Diode Forward Voltage	$V_{SD}$	$I_S=11A, V_{GS}=0V$	-	-	1.4	V
Reverse Recovery Time <sup>4</sup>	$T_{rr}$	$I_S=11A, V_{GS}=0V, dI_F/dt=100A/\mu s$	-	306	-	nS
Reverse Recovery Charge <sup>4</sup>	$Q_{rr}$		-	3.7	-	$\mu C$
Reverse Recovery Peak Current <sup>4</sup>	$I_{rrm}$		-	24	-	A

Note:

- $L=79\text{mH}, V_{DD}=100V, R_G=25\Omega$ , starting temperature  $T_J=25^\circ\text{C}$ .
- $V_{DS}=0-400V, I_{SD}\leq I_S, T_J=25^\circ\text{C}$ .
- $V_{DS}=0-480V$ .
- Pulse test: pulse width  $\leq 300\mu s$ , duty cycle  $\leq 2\%$ .
- Essentially independent of operating temperature.

### Typical Electrical and Thermal Characteristic Curves

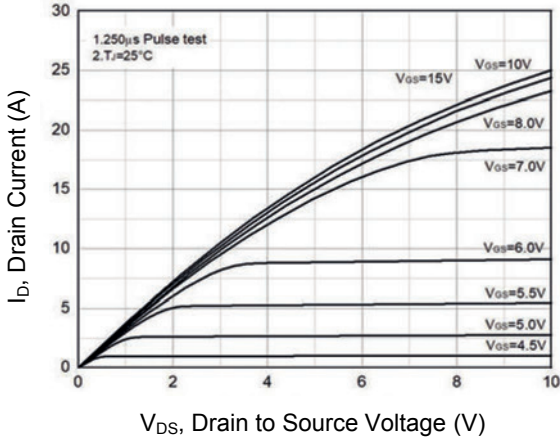


Figure 1. Typical Output Characteristics

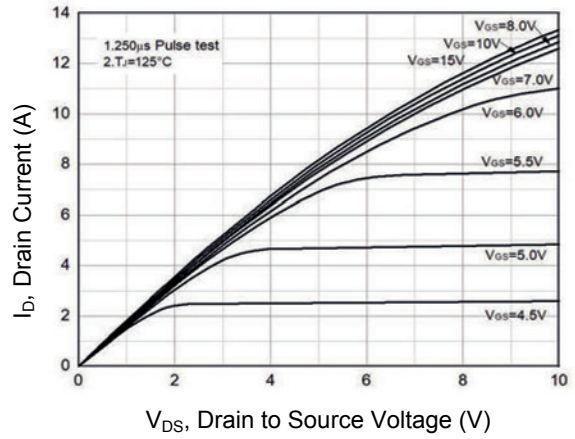


Figure 2. Typical Output Characteristics

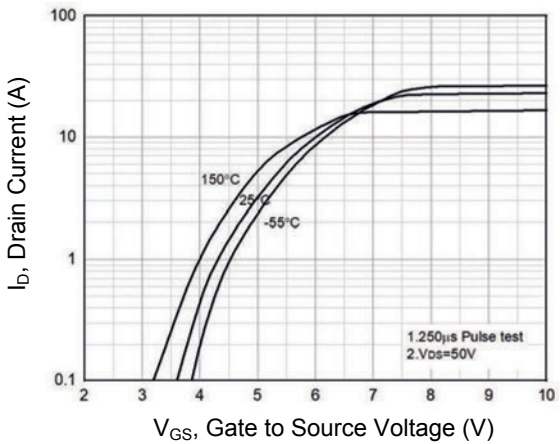


Figure 3. Transfer Characteristics

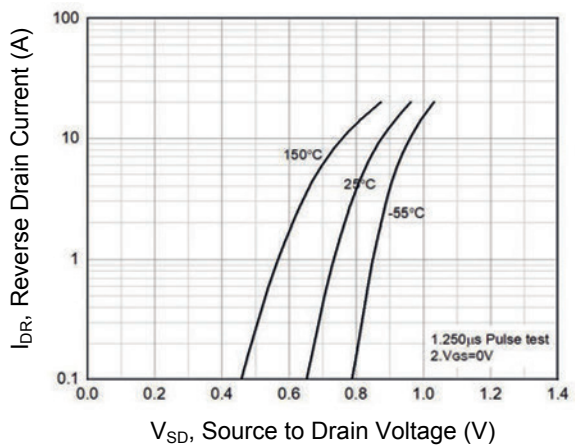


Figure 4. Body Diode Characteristics

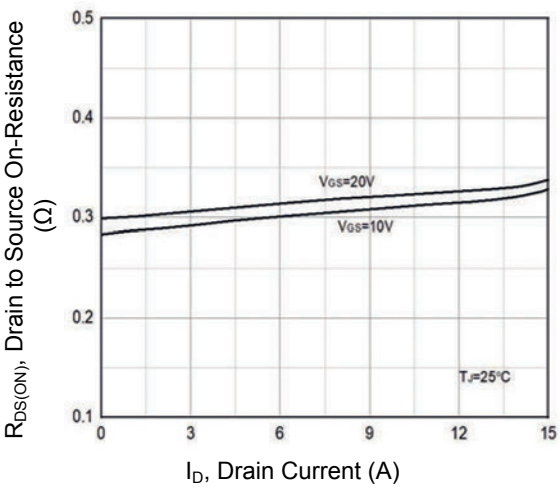


Figure 5. R<sub>DS(ON)</sub> vs. Drain Current

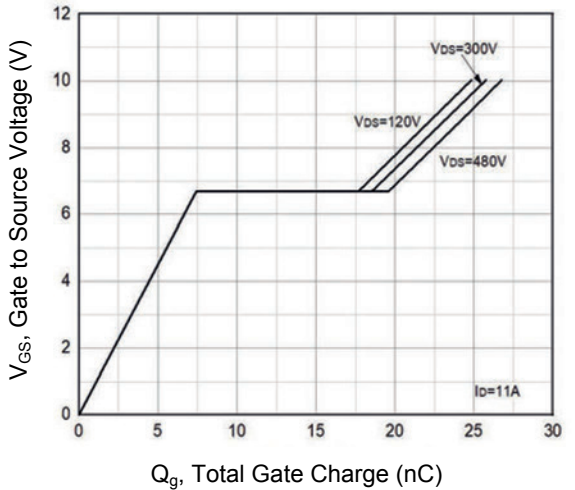


Figure 6. Gate Charge Characteristics

## Typical Electrical and Thermal Characteristic Curves

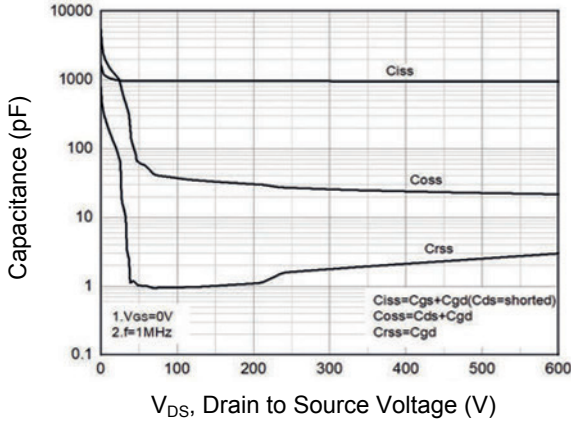


Figure 7. Capacitance Characteristics

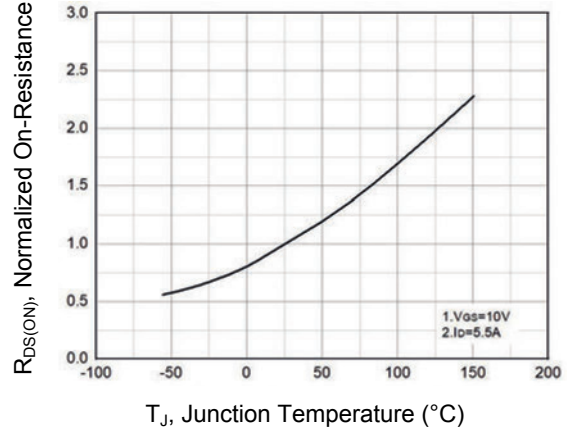


Figure 8. Normalized  $R_{DS(ON)}$  vs.  $T_J$

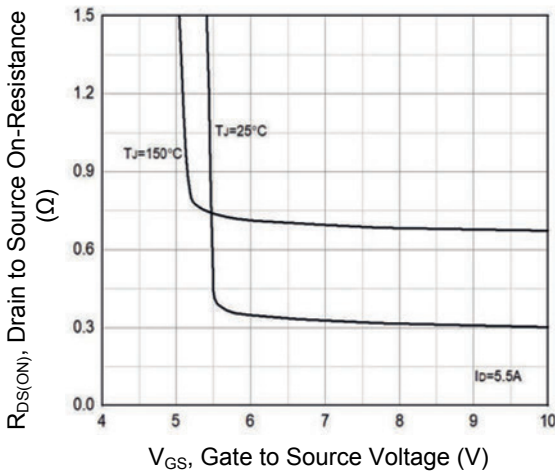


Figure 9.  $R_{DS(ON)}$  vs.  $V_{GS}$

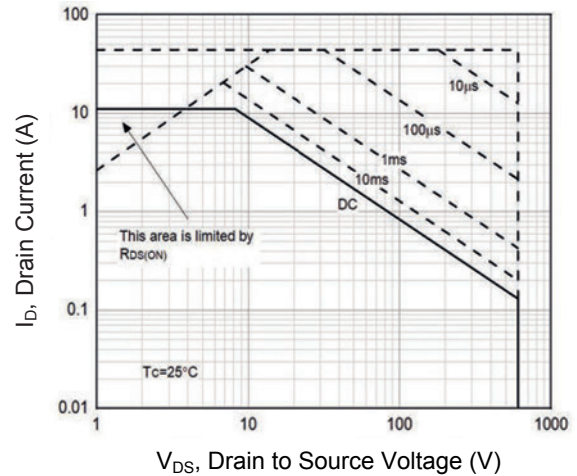


Figure 10. Safe Operation Area

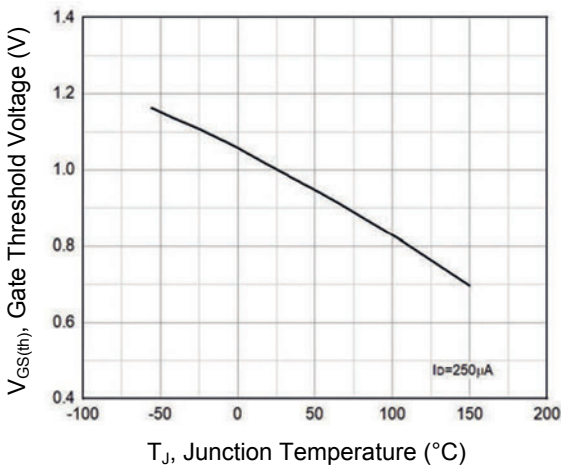


Figure 11. Gate Threshold Voltage vs.  $T_J$

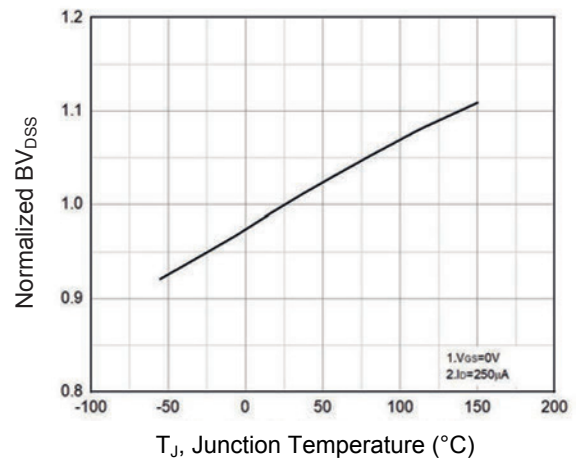


Figure 12. Normalized  $BV_{DS}$  vs.  $T_J$

## Typical Electrical and Thermal Characteristic Curves

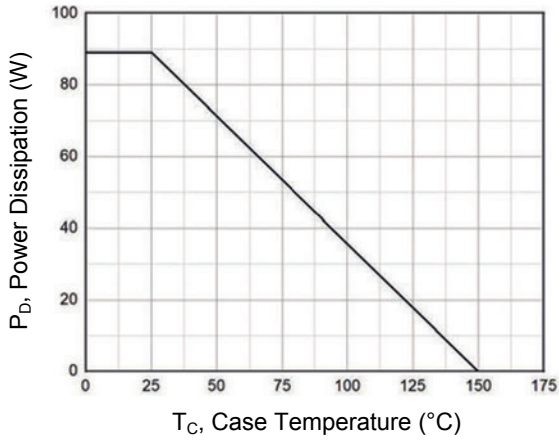


Figure 13. Power Dissipation vs.  $T_c$

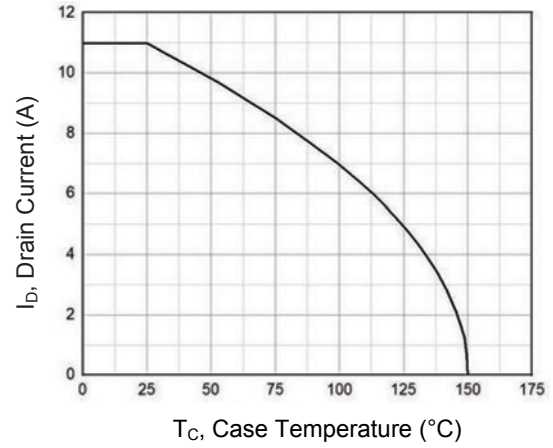


Figure 14. Drain Current vs.  $T_c$

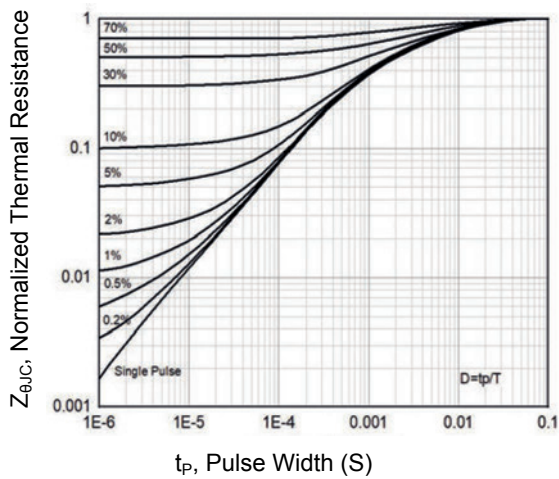
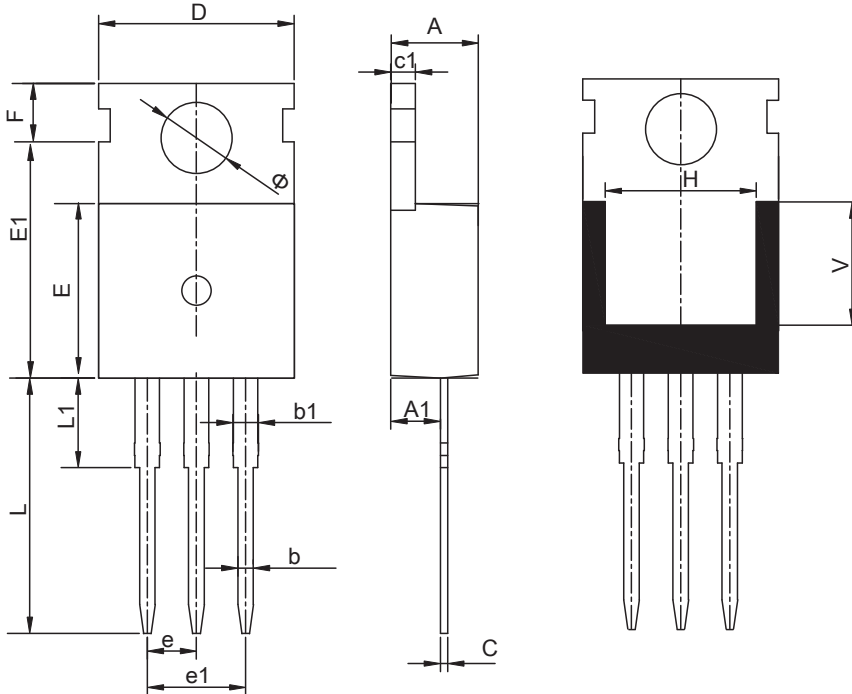


Figure 15. Transient Thermal Impedance vs.  $t_p$

## Package Outline Dimensions (TO-220)



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.40	4.60	0.173	0.181
A1	2.25	2.70	0.089	0.106
b	0.71	0.91	0.028	0.036
b1	1.17	1.37	0.046	0.054
C	0.33	0.65	0.013	0.026
c1	1.20	1.40	0.047	0.055
D	9.91	10.25	0.390	0.404
E	8.95	9.75	0.352	0.384
E1	12.65	13.00	0.498	0.512
e	2.54 TYP		0.100 TYP	
e1	4.98	5.18	0.196	0.204
F	2.65	2.95	0.104	0.116
H	7.90	8.10	0.311	0.319
L	12.90	13.40	0.508	0.528
L1	2.68	3.25	0.106	0.128
V	6.90 REF		0.272 REF	
Φ	3.40	3.80	0.134	0.150

## Order Information

Device	Package	Marking	Carrier	Quantity
GSJH60R360	TO-220	H60R360	Tube	50pcs / Tube